

Search Notes

Application/Control No.

10/701,156

Examiner

Shih-wen Hsieh

Applicant(s)/Patent under
Reexamination

IWATA, YUJI

Art Unit

2861

SEARCHED

Class	Subclass	Date	Examiner
347	100-102, 15,43,105 125,128	12/8/2005	SWH
392	417	12/8/2005	SWH
34	266-267	12/8/2005	SWH
34	273	12/8/2005	SWH
219	216	12/8/2005	SWH

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
east text search (see attached)	12/7/2005	SWH